

# **Test Report**

Report No. : MTi241205013-01E1

Date of issue : 2025-03-21

Applicant : Shenzhen Yifeng Intelligent Technology Co., Ltd.

Product : 10K Magnetic Wireless Power Bank

Model(s) : P17

FCC ID : 2AXY5-P17

Shenzhen Microtest Co., Ltd.

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Test Result Certification	n			
Applicant	Shenzhen Yifeng Intelligent Technology Co., Ltd.			
Applicant Address	201, Building 4, Sanwei Chaxi Industrial Zone, Sanwei Community, Hang Cheng Street, Bao An District, Shenzhen, China			
Manufacturer	Shenzhen Yifeng Intelligent Technol	logy Co., Ltd.		
Manufacturer Address	201, Building 4, Sanwei Chaxi Indus Hang Cheng Street, Bao An District			
Product description				
Product name	10K Magnetic Wireless Power Bank			
Trademark	YFZN			
Model name	P17			
Series Model(s)	N/A			
Standards	47 CFR Part 15C			
Test Method	ANSI C63.10-2013			
Testing Information		Micro		
Date of test	2024-12-25 to 2024-12-28			
Test result	Pass			
Prepared by:	James Qin	James ain		
Reviewed by:	David Lee	James arm Dourid Lee Lewis lion		
Approved by:	Lewis Lian	lewis lian		



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### 1 General Description

### 1.1 Description of the EUT

Product name:	10K Magnetic Wireless Power Bank
Model name:	P17
Series Model(s):	N/A
Model difference:	N/A
Electrical rating:	Type-C Input: DC 5V/ 3A, 9V/ 2A, 12V/ 1.5A Type-C Output: 5V/ 3A, 9V/ 3A, 12V/ 2.5A, 15V/ 2A Wireless Charger Output: 15W Max Battery capacity: 5000mAh 7.7V 38.5Wh
Accessories:	N/A
Hardware version:	V1.2
Software version:	0081F011
Test sample(s) number:	MTi241205013-01S1001
RF specification	
Operating frequency range:	115-205kHz(5W/ 7.5W/ 10W) 360kHz(15W)
Modulation type:	ASK

#### 1.2 Description of test modes

No.	Emission test modes
Mode1	Charging+Wireless Output(5W)
Mode2	Charging+Wireless Output(7.5W)
Mode3	Charging+Wireless Output(10W)
Mode4	Wireless Output(5W)
Mode5 Wireless Output(7.5W)	
Mode6 Wireless Output(10W)	
Mode7	Wireless Output(15W)
Mode8	Stand by



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#### 1.3 Environmental Conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature:	15°C ~ 35°C	
Humidity:	20% RH ~ 75% RH	
Atmospheric pressure:	98 kPa ~ 101 kPa	

#### 1.4 Description of support units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Support equipment list						
Description	Model	Serial No.	Manufacturer			
HUAWEI QUICK CHARGE(65W)	HW-200200ZP1	JN67LSN7N03451	HUAWEI			
wireless charging load	YBZ3.0	/	YBZ			
Support cable list		LOS <sup>L</sup>				
Description	Length (m)	From	То			
/	100	/	/			

#### 1.5 Measurement uncertainty

Measurement	Uncertainty
Conducted emissions (AMN 150kHz~30MHz)	±3.1dB
Occupied channel bandwidth	±3 %
Radiated spurious emissions (9kHz~30MHz)	±4.3dB
Radiated spurious emissions (30MHz~1GHz)	±4.7dB
Temperature	±1 °C
Humidity	±5%

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



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### 2 Summary of Test Result

No.	Item	Standard	Requirement	Result	
1	Antenna requirement	47 CFR Part 15C	47 CFR Part 15.203	Pass	
2	Conducted Emission at AC power line	47 CFR Part 15C	47 CFR Part 15.207(a)	Pass	
3	20dB Occupied Bandwidth	47 CFR Part 15C	47 CFR Part 15.215(c)	Pass	
4	Emissions in frequency bands (below 30MHz)	47 CFR Part 15C	47 CFR Part 15.209	Pass	
5	Emissions in frequency bands (30MHz - 1GHz)	47 CFR Part 15C	47 CFR Part 15.209	Pass	



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#### 3 Test Facilities and accreditations

#### 3.1 Test laboratory

Test laboratory:	Shenzhen Microtest Co., Ltd.
Test site location:	101, No.7, Zone 2, Xinxing Industrial Park, Fuhai Avenue, Xinhe Community, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China
Telephone:	(86-755)88850135
Fax:	(86-755)88850136
CNAS Registration No.:	CNAS L5868
FCC Registration No.:	448573
IC Registration No.:	21760
CABID:	CN0093
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### 4 List of test equipment

No.	Equipment	Manufacturer	Model	Serial No.	Cal. date	Cal. Due
1	Ote	Conducted Emiss	ion at AC power	line		
Alle.	EMI Test Receiver	Rohde&schwarz	ESCI3	101368	2024-03- 20	2025-03- 19
2	Artificial mains network	Schwarzbeck	NSLK 8127	183	2024-03- 21	2025-03- 20
3	Artificial Mains Network	Rohde & Schwarz	ESH2-Z5	100263	2024-03- 20	2025-03- 19
		20dB Occup	ied Bandwidth		2.0	10°
1	Wideband Radio Communication Tester	Rohde&schwarz	CMW500	149155	2024-03- 20	2025-03- 19
2	ESG Series Analog Ssignal Generator	Agilent	E4421B	GB400512 40	2024-03- 21	2025-03- 20
3	PXA Signal Analyzer	Agilent	N9030A	MY513502 96	2024-03- 21	2025-03- 20
4	Synthesized Sweeper	Agilent	83752A	3610A019 57	2024-03- 21	2025-03- 20
5	MXA Signal Analyzer	Agilent	N9020A	MY501434 83	2024-03- 21	2025-03- 20
6	RF Control Unit	Tonscend	JS0806-1	19D80601 52	2024-03- 21	2025-03- 20
7	Band Reject Filter Group	Tonscend	JS0806-F	19D80601 60	2024-03- 21	2025-03- 20
8	ESG Vector Signal Generator	Agilent	N5182A	MY501437 62	2024-03- 20	2025-03- 19
9	DC Power Supply	Agilent	E3632A	MY400276 95	2024-03- 21	2025-03- 20
	Em	nissions in frequenc	y bands (below	30MHz)		
10	EMI Test Receiver	Rohde&schwarz	ESCI7	101166	2024-03- 20	2025-03- 19
2	Active Loop Antenna	Schwarzbeck	FMZB 1519 B	00066	2024-03- 23	2025-03- 22
3	Amplifier	Hewlett-Packard	8447F	3113A0618 4	2024-03- 20	2025-03- 19
	Em	issions in frequency	y bands (30MHz	- 1GHz)		477
1	EMI Test Receiver	Rohde&schwarz	ESCI7	101166	2024-03- 20	2025-03- 19
2	TRILOG Broadband Antenna	schwarabeck	VULB 9163	9163-1338	2023-06-11	2025-06- 10
3	Active Loop Antenna	Schwarzbeck	FMZB 1519 B	00066	2024-03- 23	2025-03- 22
4	Amplifier	Hewlett-Packard	8447F	3113A0618 4	2024-03- 20	2025-03- 19



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### 5 Evaluation Results (Evaluation)

#### 5.1 Antenna requirement

et Co.	Refer to 47 CFR Part 15.203, an intentional radiator shall be designed
(0)	to ensure that no antenna other than that furnished by the responsible
Test Requirement:	party shall be used with the device. The use of a permanently attached
rest Requirement.	antenna or of an antenna that uses a unique coupling to the intentional
<i>k</i>	radiator shall be considered sufficient to comply with the provisions of
	this section.

#### 5.1.1 Conclusion:

The antenna of the EUT is permanently attached.

The EUT complies with the requirement of FCC PART 15.203.



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### 6 Radio Spectrum Matter Test Results (RF)

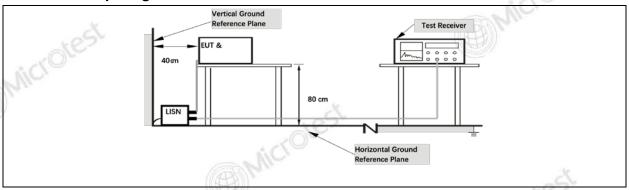
### 6.1 Conducted Emission at AC power line

Except as shown in paragraphs (b)and (c)of this section, for an intentional radiator that is designed to be connected to the public (AC) power line, the radio frequency voltage that is conducted ba onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 μH/50 ohms line impedance stabilization network (LISN).					
Test Limit:	Frequency of emission (MHz) Conducted limit (dBµV)		() ACT		
		Quasi-peak	Average		
	0.15-0.5	66 to 56*	56 to 46*		
	0.5-5	56	46		
	5-30 60 50				
12-	*Decreases with the logarithm of the frequency.				
Test Method:	ANSI C63.10-2013 section 6.2				
Procedure:	Refer to ANSI C63.10-2013 section 6.2, standard test method for ac power-line conducted emissions from unlicensed wireless devices				

#### 6.1.1 E.U.T. Operation:

Operating Environment:							
Temperature:	Temperature: 21.5 °C Humidity: 45 % Atmospheric Pressure: 99 kPa						
Pre test mode:	Mode1, Mode2, Mode3						
			All of the listed pre-test mode were tested, only the data of the worst mode (Mode3) is recorded in the report				

#### 6.1.2 Test Setup Diagram:

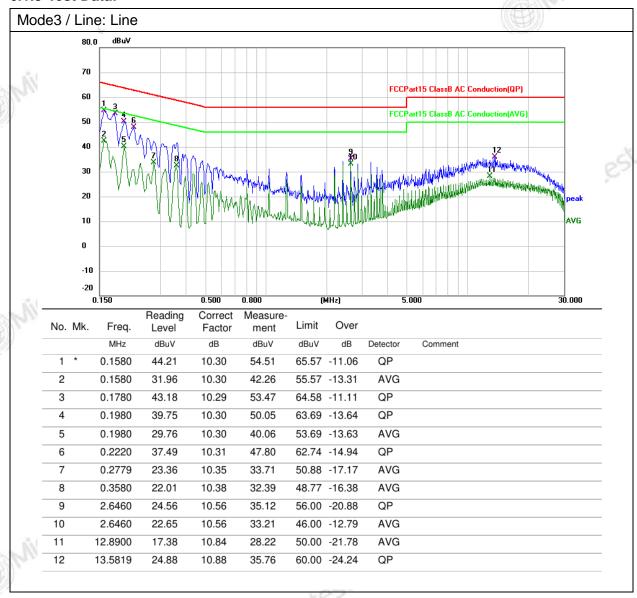




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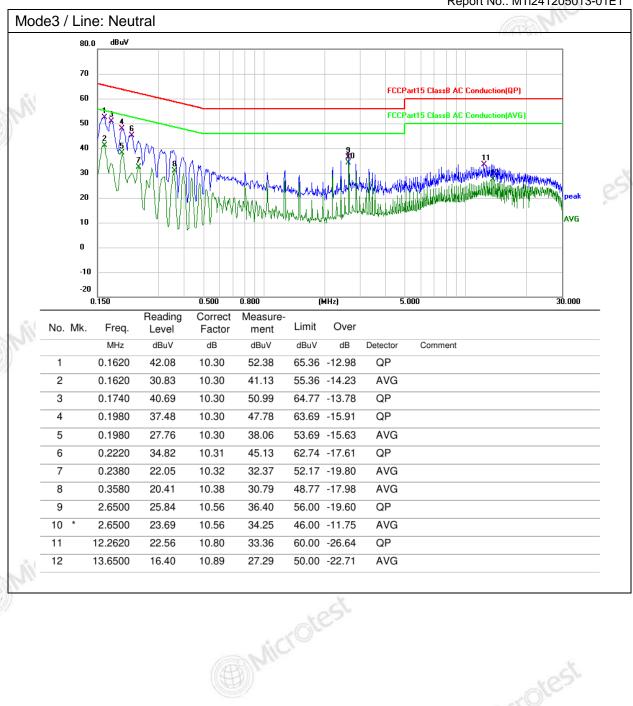
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#### 6.1.3 Test Data:





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#### 6.2 20dB Occupied Bandwidth

6.2 20dB Occupied	Bandwidth			
Test Requirement:	47 CFR Part 15.215(c)			
Test Limit:	Refer to 47 CFR 15.215(c), intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.			
Test Method:	ANSI C63.10-2013, section 6.9.2	-O/C-		
Procedure:	a) The spectrum analyzer center fre channel center frequency. The span spectrum analyzer shall be between OBW.	range for the EMI receiver or two times and five times the		
Microtest	b) The nominal IF filter bandwidth (3 1% to 5% of the OBW and video ba approximately three times RBW, unapplicable requirement. c) Set the reference level of the inst signal from exceeding the maximum operation. In general, the peak of the than [10 log (OBW/RBW)] below the	ndwidth (VBW) shall be less otherwise specified by the rument as required, keeping the input mixer level for linear e spectral envelope shall be more		
Microtest.	is given in 4.1.5.2. d) Steps a) through c) might require specified tolerances. e) The dynamic range of the instrummore than 10 dB below the target "-if the requirement calls for measuring noise floor at the selected RBW shareference value. f) Set detection mode to peak and truly g) Determine the reference value: Summodulated carrier or modulated strace to stabilize. Set the spectrum a level of the displayed trace (this is the h) Determine the "-xx dB down amp xx]. Alternatively, this calculation madelta function of the instrument.	nent at the selected RBW shall be -xx dB down" requirement; that is, ing the -20 dB OBW, the instrument all be at least 30 dB below the race mode to max hold. Set the EUT to transmit an aignal, as applicable. Allow the analyzer marker to the highest the reference value). Dilitude" using [(reference value) - ay be made by using the marker-		
Microtest	i) If the reference value is determined turn the EUT modulation ON, and example a new trace on the spectrum analyzy stabilize. Otherwise, the trace from it is place two markers, one at the low highest frequency of the envelope of each marker is at or slightly below the determined in step h). If a marker is amplitude" value, then it shall be as The occupied bandwidth is the frequency of the spectral display, such that is the frequency of the spectral display, such below the "-xx dB down amplitude" of the spectral display, such below the "-xx dB down amplitude" of the spectral display is the spectral display.	ither clear the existing trace or start ter and allow the new trace to step g) shall be used for step j). The step of the spectral display, such that the "-xx dB down amplitude" below this "-xx dB down close as possible to this value. The user of the lowest frequency of the ch that the marker is at or slightly		



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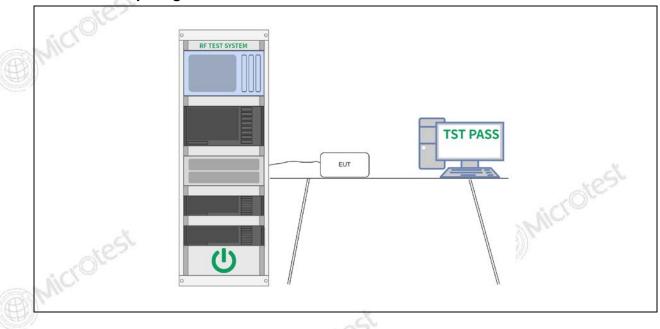
marker-delta function and move the marker to the other side of the
emission until the delta marker amplitude is at the same level as the
reference marker amplitude. The marker-delta frequency reading at
this point is the specified emission bandwidth.
k) The occupied bandwidth shall be reported by providing plot(s) of the
measuring instrument display; the plot axes and the scale units per
division shall be clearly labeled. Tabular data may be reported in

#### 6.2.1 E.U.T. Operation:

Operating Environment:							
Temperature:	22.9 °	C	Humidity: 41 °	%	Atmospheric Pressure:	101 kPa	
Pre test mode: Mode1, Mode2, Mode3, Mode4, Mode5, Mode6, Mode7, Mode8						7, Mode8	
Final test mode:  All of the listed pre-test mode were tested, only the data of mode (Mode6, Mode7) is recorded in the report					a of the worst		

addition to the plot(s).

#### 6.2.2 Test Setup Diagram:





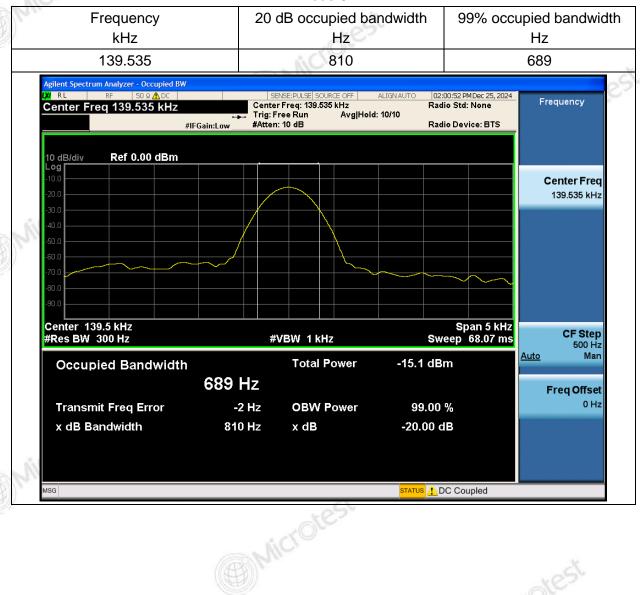
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#### 6.2.3 Test Data:

**Note:** Because the measured signal is CW-like, adjusting the RBW per C63.10 would not be practical since measurement bandwidth will always follow the RBW. The RBW is set to 300 Hz to perform the occupied bandwidth test.

Mode 6



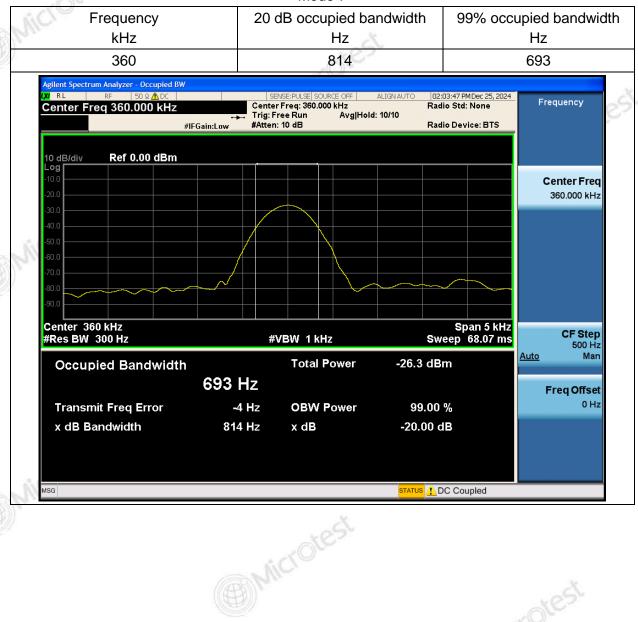


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**Note:** Because the measured signal is CW-like, adjusting the RBW per C63.10 would not be practical since measurement bandwidth will always follow the RBW. The RBW is set to 300 Hz to perform the occupied bandwidth test.

Mode 7





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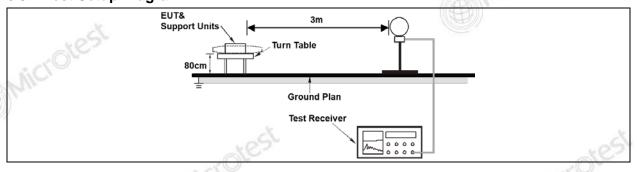
#### 6.3 Emissions in frequency bands (below 30MHz)

Test Requirement:	47 CFR Part 15.209	((((1)))	
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measuremen t distance (meters)
Mr.	0.009-0.490	2400/F(kHz)	300
	0.490-1.705	24000/F(kHz)	30
	1.705-30.0	30	30
	30-88	100 **	3
	88-216	150 **	3
	216-960	200 **	3
	Above 960	500	3
Microtest Microtest	permitted under other in the emission table at The emission limits shownessurements employ frequency bands 9–90 Radiated emission limit measurements employ As shown in § 15.35(b) strength limits in paragaverage limits. However, not exceed the maximum more than 20 dB under operation under paragare.	reration within these frequent sections of this part, e.g., §§ bove, the tighter limit applies own in the above table are bring a CISPR quasi-peak det kHz, 110–490 kHz and above the section of the section of the peak field strength of th	15.231 and 15.241. s at the band edges. ased on sector except for the ve 1000 MHz. based on 0 MHz, the field on are based on any emission shall specified above by n. For point-to-point eak field strength
Test Method:	ANSI C63.10-2013 sec	ction 6.4	
Procedure:	ANSI C63.10-2013 sed	ction 6.4	

#### 6.3.1 E.U.T. Operation:

Operating Environment:							
Temperature: 22.5 °C Humidity: 43 % Atmospheric Pressure: 101 kPa						101 kPa	
Pre test mode: Mode1, Mode2, Mode3, Mode4, Mode5, Mode6, Mode7, Mode8					7, Mode8		
					e were tested, only the dat orded in the report	a of the worst	

#### 6.3.2 Test Setup Diagram:

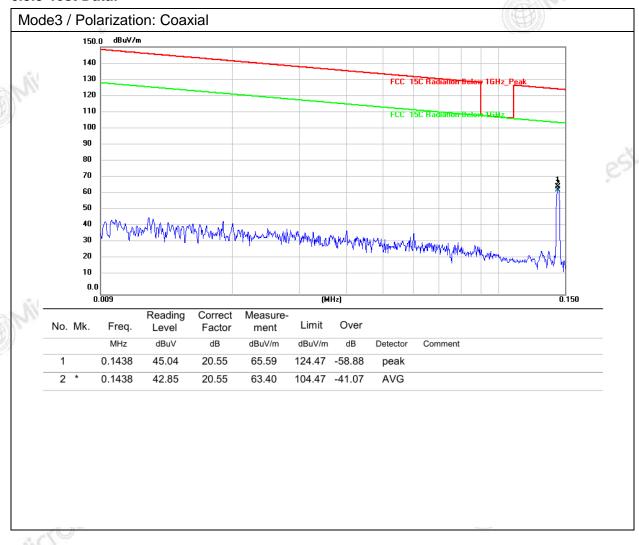




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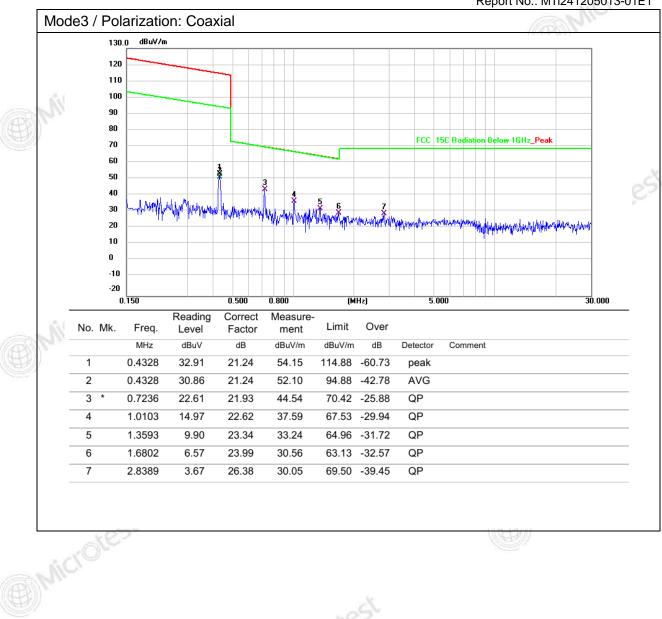
#### 6.3.3 Test Data:





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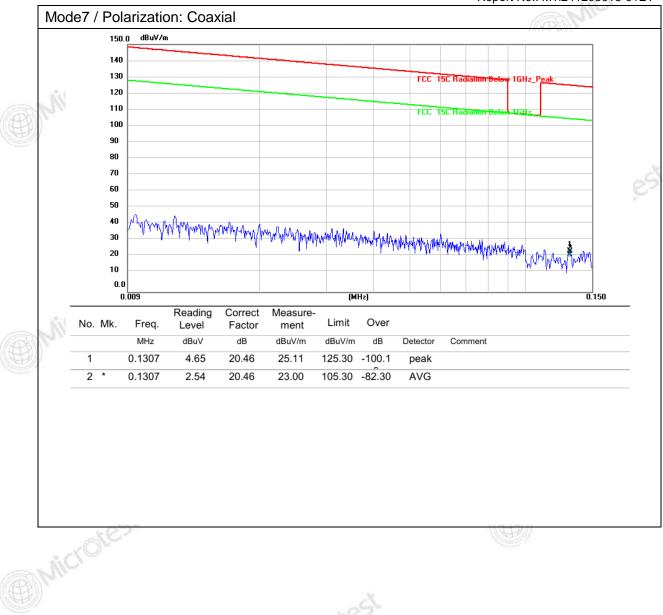
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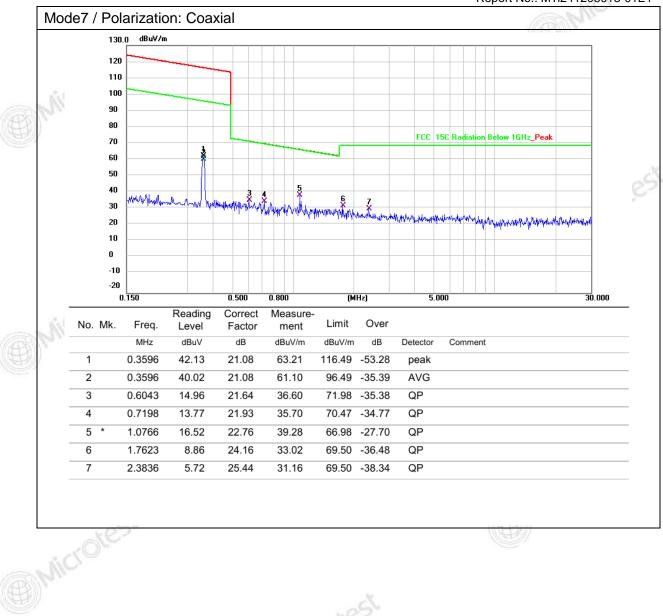
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#### 6.4 Emissions in frequency bands (30MHz - 1GHz)

Test Requirement:	47 CFR Part 15.209		
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measuremen t distance (meters)
Mr.	0.009-0.490	2400/F(kHz)	300
	0.490-1.705	24000/F(kHz)	30
	1.705-30.0	30	30
	30-88	100 **	3
	88-216	150 **	3
	216-960	200 **	3
	Above 960	500	3
Microtest est	permitted under other solution in the emission table at The emission limits show measurements employ frequency bands 9–90 Radiated emission limit measurements employ As shown in § 15.35(b) strength limits in paragaverage limits. However, not exceed the maximum more than 20 dB under operation under paragaments.	reration within these frequent sections of this part, e.g., §§ bove, the tighter limit applies own in the above table are bring a CISPR quasi-peak det kHz, 110–490 kHz and above to the these three bands are bring an average detector. In the peak field strength of	15.231 and 15.241. s at the band edges. ased on rector except for the ve 1000 MHz. based on 0 MHz, the field on are based on any emission shall specified above by a For point-to-point eak field strength
Test Method:	ANSI C63.10-2013 sed	ction 6.5	
Procedure:	ANSI C63.10-2013 sed	ction 6.5	

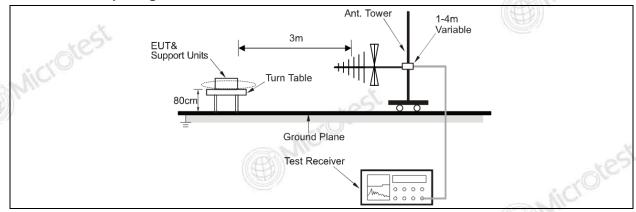
#### 6.4.1 E.U.T. Operation:

Operating Envi	ronment:				
Temperature:	26 °C	Humidity:	54 %	Atmospheric Pressure:	98.3 kPa
Pre test mode:		Mode1, Mode2, Mode3, Mode4, Mode5, Mode6, Mode7, Mode8			
Final test mode		all of the listed p mode (Mode2) is		were tested, only the dat the report	a of the worst



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#### 6.4.2 Test Setup Diagram:



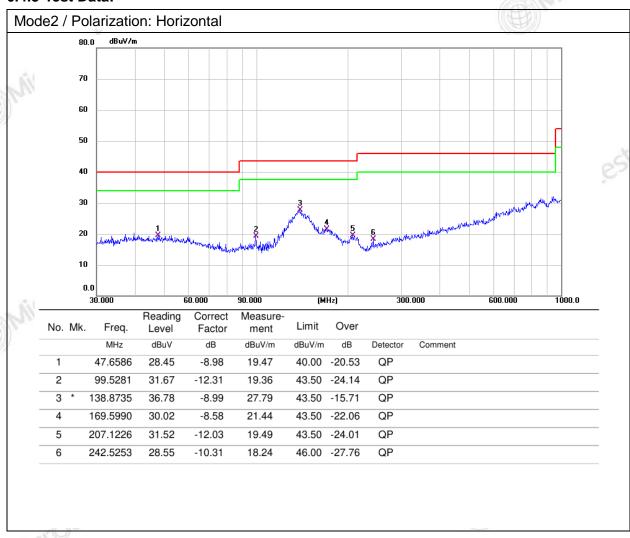




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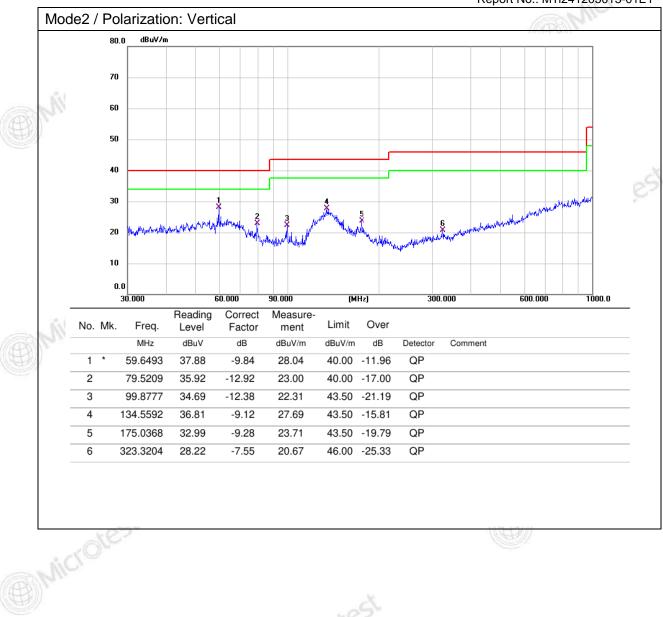
#### 6.4.3 Test Data:





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#### Photographs of the test setup

Refer to Appendix - Test Setup Photos











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### Photographs of the EUT

Refer to Appendix - EUT Photos





















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- 1. This report is invalid without the seal and signature of the laboratory.
- 2. The test results of this report are only responsible for the samples submitted. Client shall be responsible for representativeness of the sample and authenticity of the material.
- 3. The report shall not be partially reproduced without the written consent of the Laboratory.
- 4. This report is invalid if transferred, altered or tampered with in any form without authorization.
- 5. The observations or tests with special mark fall outside the scope of accreditation, and are only used for purpose of commission, research, training, internal quality control etc.
- 6. Any objection to this report shall be submitted to the laboratory within 15 days from the date of receipt of the report.

\*\*\*\*\*\* END OF REPORT \*\*\*\*\*

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